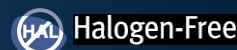




THE DATASHEET OF EPC2038



EPC2038 – Enhancement Mode Power Transistor with Integrated Reverse Gate Clamp Diode

 $V_{DS}, 100\text{ V}$
 $R_{DS(on)}, 3300\text{ m}\Omega$
 $I_D, 0.5\text{ A}$


Gallium Nitride's exceptionally high electron mobility and low temperature coefficient allows very low $R_{DS(on)}$, while its lateral device structure and majority carrier diode provide exceptionally low Q_G and zero Q_{RR} . The end result is a device that can handle tasks where very high switching frequency, and low on-time are beneficial as well as those where on-state losses dominate.

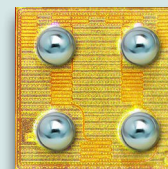
Maximum Ratings			
PARAMETER		VALUE	UNIT
V_{DS}	Drain-to-Source Voltage (Continuous)	100	V
	Drain-to-Source Voltage (up to 10,000 5 ms pulses at 150°C)	120	
I_D	Continuous ($T_A = 25^\circ\text{C}$, $R_{\theta JA} = 100^\circ\text{C/W}$)	0.5	A
	Pulsed (25°C , $T_{PULSE} = 300\ \mu\text{s}$)	0.5	
V_{GS}	Gate-to-Source Voltage	6	V
T_J	Operating Temperature	-40 to 150	°C
T_{STG}	Storage Temperature	-40 to 150	

Thermal Characteristics			
PARAMETER		TYP	UNIT
$R_{\theta JC}$	Thermal Resistance, Junction-to-Case	27	°C/W
$R_{\theta JB}$	Thermal Resistance, Junction-to-Board	91	
$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient (Note 1)	100	

Note 1: $R_{\theta JA}$ is determined with the device mounted on one square inch of copper pad, single layer 2 oz copper on FR4 board. See https://epc-co.com/epc/documents/product-training/Appnote_Thermal_Performance_of_eGaN_FETs.pdf for details.

Static Characteristics ($T_J = 25^\circ\text{C}$ unless otherwise stated)						
PARAMETER		TEST CONDITIONS	MIN	TYP	MAX	UNIT
BV_{DSS}	Drain-to-Source Voltage	$V_{GS} = 0\text{ V}$, $I_D = 125\ \mu\text{A}$	100			V
I_{DSS}	Drain-Source Leakage	$V_{DS} = 80\text{ V}$, $V_{GS} = 0\text{ V}$		20	100	μA
I_{GSS}	Gate-to-Source Forward Leakage	$V_{GS} = 5\text{ V}$, $T_J = 25^\circ\text{C}$		0.0001	0.5	mA
	Gate-to-Source Forward Leakage [#]	$V_{GS} = 5\text{ V}$, $T_J = 125^\circ\text{C}$		0.002	1	
V_F	Source-Gate Forward Voltage	$I_F = 0.2\text{ mA}$, $V_{DS} = 0\text{ V}$			2.7	V
$V_{GS(TH)}$	Gate Threshold Voltage	$V_{DS} = V_{GS}$, $I_D = 0.1\text{ mA}$	0.8	1.7	2.5	V
$R_{DS(on)}$	Drain-Source On Resistance	$V_{GS} = 5\text{ V}$, $I_D = 0.05\text{ A}$		2100	3300	$\text{m}\Omega$
V_{SD}	Source-Drain Forward Voltage	$I_S = 0.1\text{ A}$, $V_{GS} = 0\text{ V}$		2.9		V

All measurements were done with substrate connected to source.
[#] Defined by design. Not subject to production test.



EPC2038 eGaN® FETs are supplied only in passivated die form with solder bumps. Die size: 0.9 mm x 0.9 mm

Applications

Synchronous Bootstrap for:

- High Speed DC-DC Conversion
- Wireless Power Transfer
- High Frequency Hard-Switching and Soft-Switching Circuits
- Lidar/Pulsed Power Applications
- Class-D Audio

Benefits

- Ultra High Efficiency
- Ultra Low $R_{DS(on)}$
- Ultra Low Q_G
- Ultra Small Footprint



Dynamic Characteristics ($T_j = 25^\circ\text{C}$ unless otherwise stated)

PARAMETER		TEST CONDITIONS	MIN	TYP	MAX	UNIT
C_{ISS}	Input Capacitance	$V_{DS} = 50\text{ V}, V_{GS} = 0\text{ V}$		7	8.4	pF
C_{RSS}	Reverse Transfer Capacitance			0.02		
C_{OSS}	Output Capacitance			1.6	2.4	
$C_{OSS(ER)}$	Effective Output Capacitance, Energy Related (Note 2)	$V_{DS} = 0\text{ to }50\text{ V}, V_{GS} = 0\text{ V}$		2.2		pF
$C_{OSS(TR)}$	Effective Output Capacitance, Time Related (Note 3)			2.7		
R_G	Gate Resistance			4.8		Ω
Q_G	Total Gate Charge	$V_{DS} = 50\text{ V}, V_{GS} = 5\text{ V}, I_D = 0.05\text{ A}$		44		pC
Q_{GS}	Gate-to-Source Charge	$V_{DS} = 50\text{ V}, I_D = 0.05\text{ A}$		20		
Q_{GD}	Gate-to-Drain Charge			4		
$Q_{G(TH)}$	Gate Charge at Threshold			18		
Q_{OSS}	Output Charge	$V_{DS} = 50\text{ V}, V_{GS} = 0\text{ V}$		134		
Q_{RR}	Source-Drain Recovery Charge			0		

All measurements were done with substrate connected to source.

Note 2: $C_{OSS(ER)}$ is a fixed capacitance that gives the same stored energy as C_{OSS} while V_{DS} is rising from 0 to 50% BV_{DSS} .

Note 3: $C_{OSS(TR)}$ is a fixed capacitance that gives the same charging time as C_{OSS} while V_{DS} is rising from 0 to 50% BV_{DSS} .

Figure 1: Typical Output Characteristics at 25°C

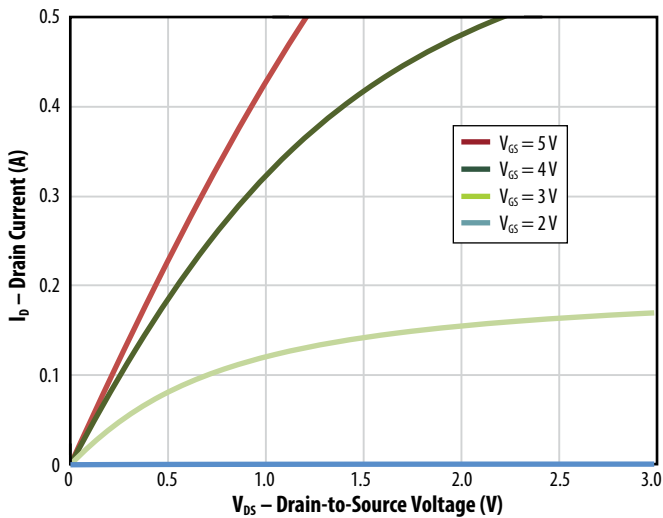


Figure 2: Transfer Characteristics

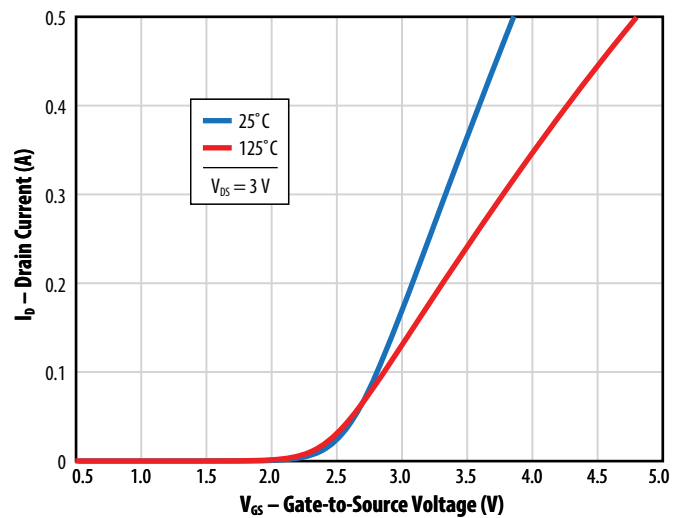


Figure 3: $R_{DS(on)}$ vs. V_{GS} for Various Drain Currents

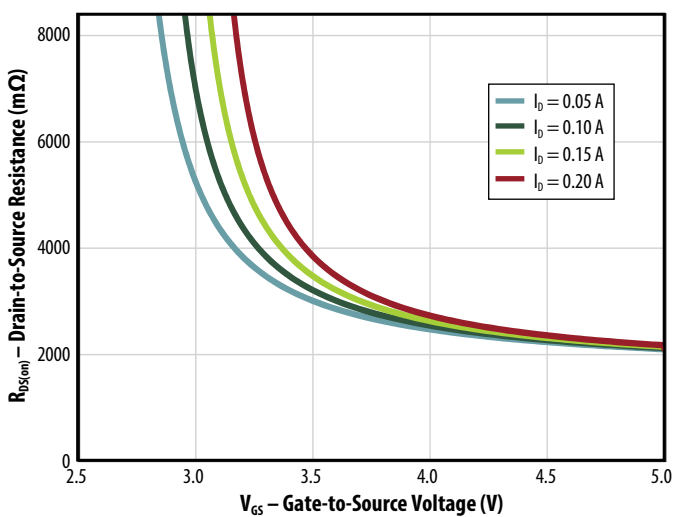


Figure 4: $R_{DS(on)}$ vs. V_{GS} for Various Temperatures

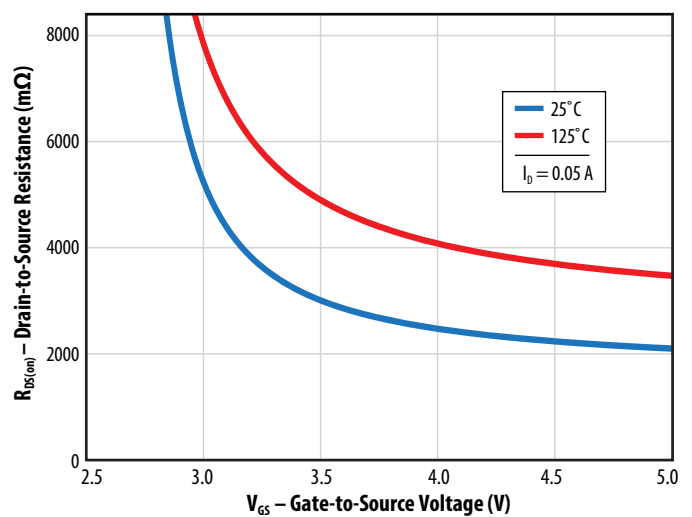


Figure 5a: Capacitance (Linear Scale)

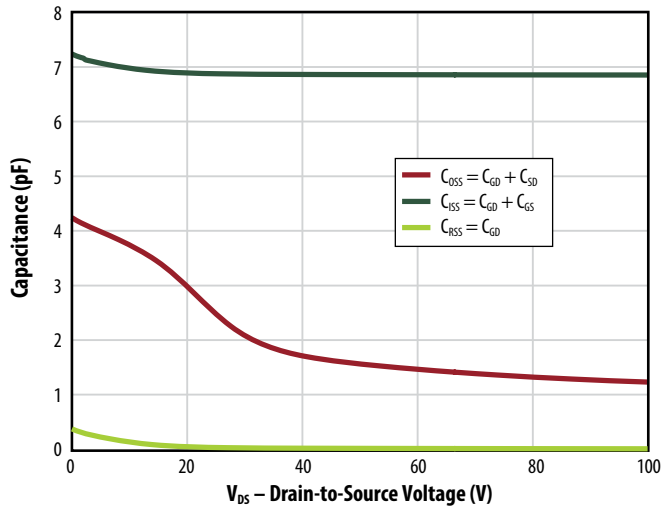


Figure 5b: Capacitance (Log Scale)

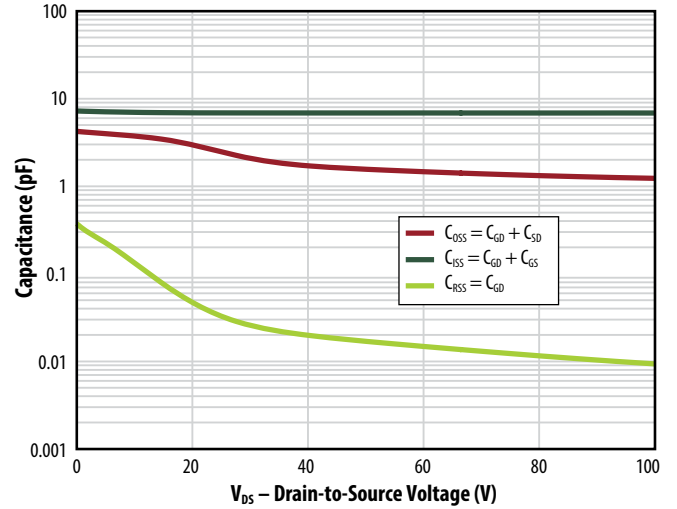


Figure 6: Gate Charge

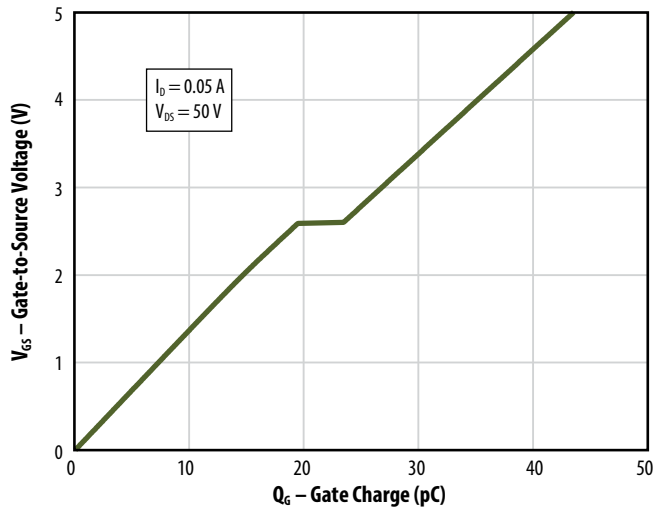


Figure 7: Reverse Drain-Source Characteristics

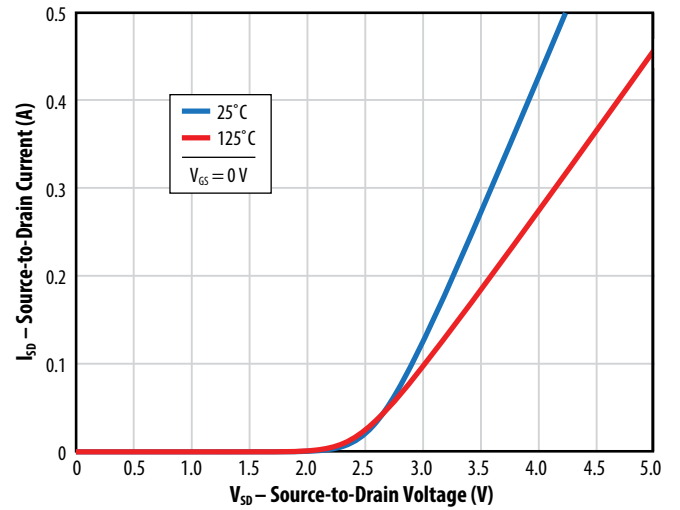


Figure 8: Normalized On-State Resistance vs. Temperature

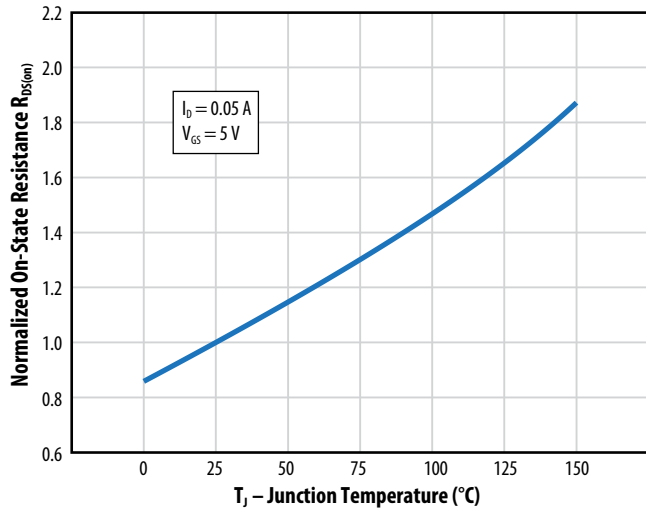
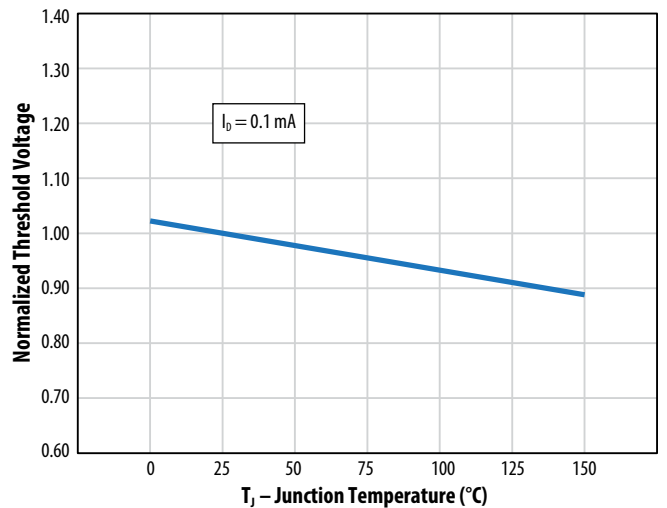


Figure 9: Normalized Threshold Voltage vs. Temperature



All measurements were done with substrate shorted to source.

Figure 10: Transient Thermal Response Curves

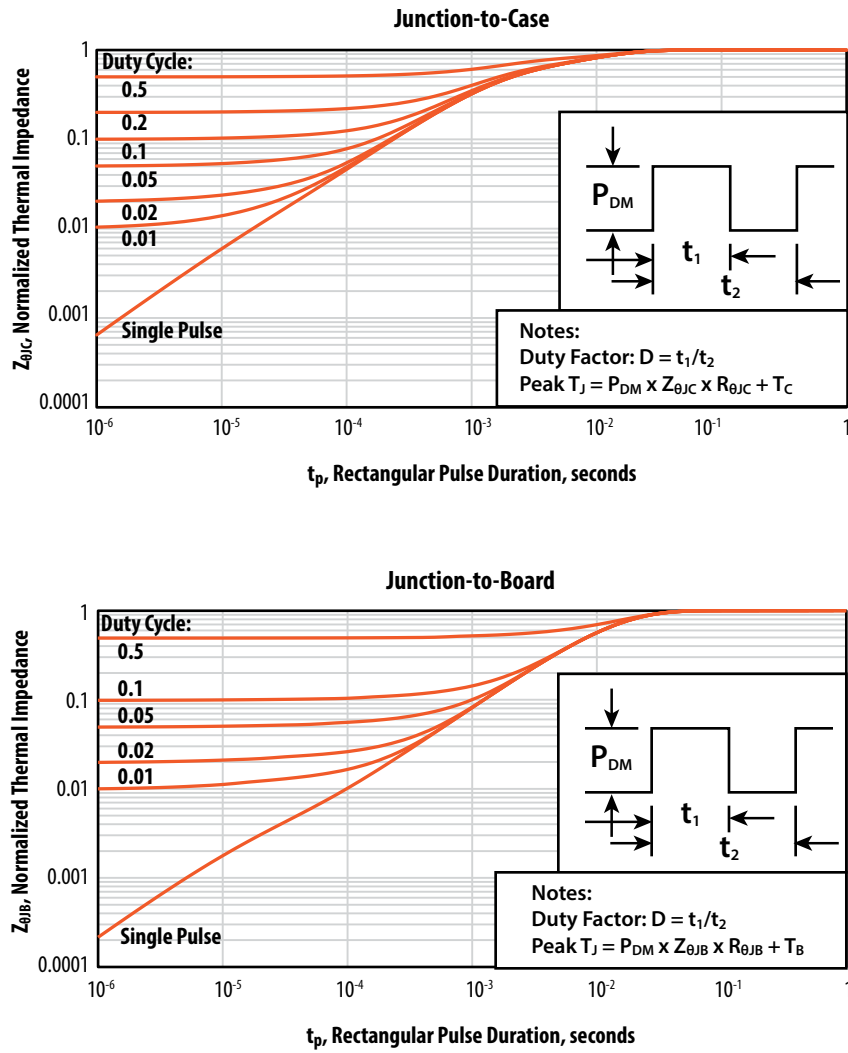
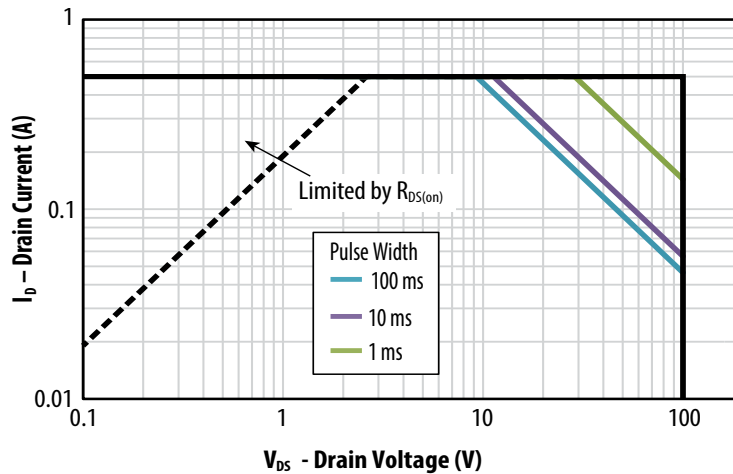
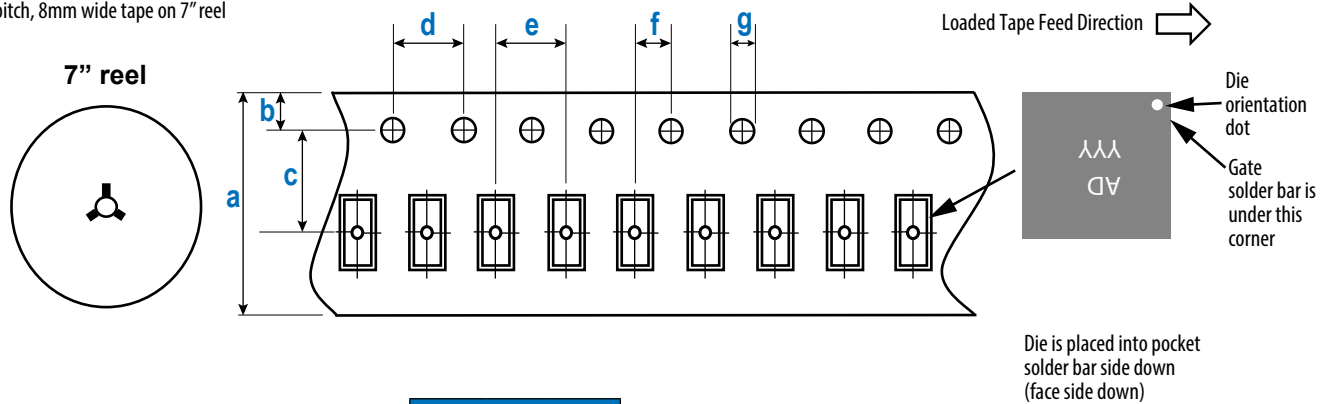


Figure 11: Safe Operating Area



TAPE AND REEL CONFIGURATION

4mm pitch, 8mm wide tape on 7" reel

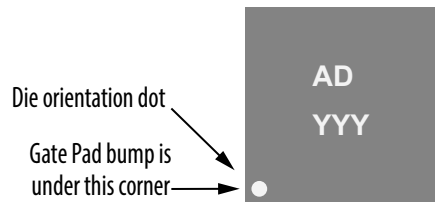


EPC2038 (Note 1)	Dimension (mm)		
	Target	MIN	MAX
a	8.00	7.90	8.30
b	1.75	1.65	1.85
c (Note 2)	3.50	3.45	3.55
d	4.00	3.90	4.10
e	4.00	3.90	4.10
f (Note 2)	2.00	1.95	2.05
g	1.50	1.50	1.60

Note 1: MSL 1 (moisture sensitivity level 1) classified according to IPC/ JEDEC industry standard.

Note 2: Pocket position is relative to the sprocket hole measured as true position of the pocket, not the pocket hole.

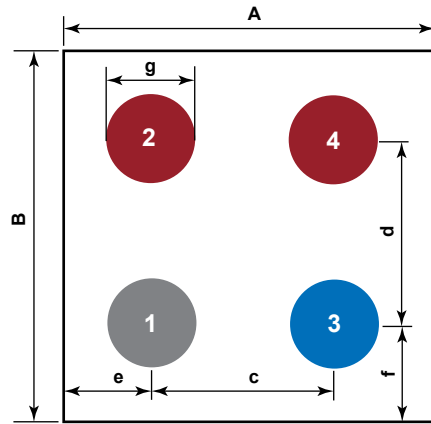
DIE MARKINGS



Part Number	Laser Markings	
	Part # Marking Line 1	Lot_Date Code Marking Line 2
EPC2038	AD	YYY

DIE OUTLINE

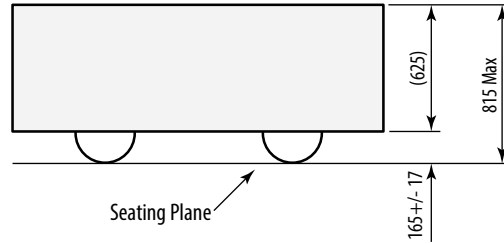
Solder Bump View



Pads 1 is Gate;
Pad 3 is Drain;
Pads 2, 4 are Source

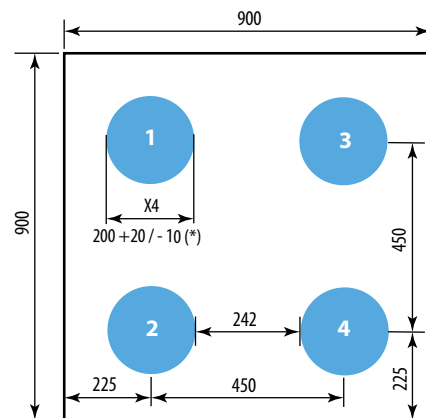
DIM	MIN	Nominal	MAX
A	870	900	930
B	870	900	930
c	450	450	450
d	450	450	450
e	210	225	240
f	210	225	240
g	187	208	229

Side View



RECOMMENDED LAND PATTERN

(measurements in μm)



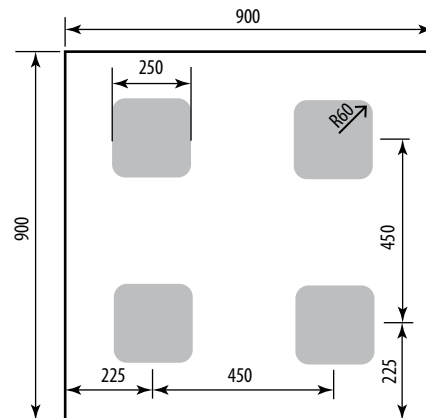
* minimum 190

The land pattern is solder mask defined
Solder mask is 10 μm smaller per side than bump

Pads 1 is Gate;
Pad 3 is Drain;
Pads 2, 4 are Source

RECOMMENDED STENCIL DRAWING

(measurements in μm)



Recommended stencil should be 4 mil (100 μm) thick, must be laser cut, openings per drawing.

Intended for use with SAC305 Type 4 solder, reference 88.5% metals content.

Additional assembly resources available at
<https://epc-co.com/epc/DesignSupport/AssemblyBasics.aspx>

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